

Notice of References Cited	Application/Control No. 10/598,502		Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner MARK L. SHEVIN		Art Unit 1793	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,521,062	02-2003	Bartholomeusz et al.	148/674
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English translation of Ueno JP 2002-069623, published March 8 th , 2002, 26 pages total.
	V	English translation of Ueno JP 2002-208125, published July 28 th , 2002, 23 pages total.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.